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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	KET NO. CONFIRMATION NO.		
10/800,738 03/16/2004		Kimikazu Matsumoto	089367-0125	1166		
22428	7590 01/03/2006		EXAM	EXAMINER		
	ND LARDNER LLP	KIM, RICHARD H				
SUITE 500 3000 K STR	EET NW	ART UNIT	PAPER NUMBER			
WASHING	ΓON, DC 20007	2871				
			DATE MAILED: 01/03/2006			

Please find below and/or attached an Office communication concerning this application or proceeding.

			Application No.		Applicant(s)				
			10/800,738		MATSUMOTO, KIMIKAZU				
Office Action Summary		-	Examiner		Art Unit				
		1	Richard H. Kim		2871				
Period fo	The MAILING DATE of this commur or Reply	nication appe	ars on the cover shee	t with the co	orrespondence ad	idress			
WHIC - Exter after - If NO - Failu Any (ORTENED STATUTORY PERIOD F CHEVER IS LONGER, FROM THE Nations of time may be available under the provisions SIX (6) MONTHS from the mailing date of this come period for reply is specified above, the maximum set to reply within the set or extended period for reply reply received by the Office later than three months and patent term adjustment. See 37 CFR 1.704(b).	MAILING DATES of 37 CFR 1.136 munication. tatutory period will y will, by statute, c	TE OF THIS COMMU (a). In no event, however, ma I apply and will expire SIX (6) I ause the application to becom	JNICATION by a reply be time MONTHS from to BANDONED	ely filed he mailing date of this c) (35 U.S.C. § 133).				
Status									
1)⊠	Responsive to communication(s) file	ed on 18 Oct	tober 2005						
•	Responsive to communication(s) filed on <u>18 October 2005</u> . This action is FINAL . 2b)⊠ This action is non-final.								
3) Since this application is in condition for allowance except for formal matters, prosecution as to the m									
٠,٣	closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.								
Dispositi	on of Claims								
4) 🖂	4)⊠ Claim(s) <u>1-10</u> is/are pending in the application.								
·-	4a) Of the above claim(s) is/are withdrawn from consideration.								
	Claim(s) is/are allowed.								
· · · · · · · · · · · · · · · · · · ·	Claim(s) <u>1-10</u> is/are rejected.								
7)	· · · · · · · · · · · · · · · · · · ·								
8)□	Claim(s) are subject to restrict	ction and/or	election requirement.						
Applicati	on Papers								
9)□	The specification is objected to by th	e Examiner.							
10)	The drawing(s) filed on is/are	: a) <u>□</u> accep	oted or b) objected	to by the E	xaminer.				
	Applicant may not request that any obje	ction to the dr	awing(s) be held in abe	yance. See	37 CFR 1.85(a).				
	Replacement drawing sheet(s) including	g the correctio	n is required if the draw	ving(s) is obje	ected to. See 37 C	FR 1.121(d).			
11)	The oath or declaration is objected to	o by the Exa	miner. Note the attac	hed Office	Action or form P	ΓΟ-152.			
Priority ι	ınder 35 U.S.C. § 119		•						
-	Acknowledgment is made of a claim ☐ All b)☐ Some * c)☐ None of:	for foreign p	priority under 35 U.S.0	C. § 119(a)-	·(d) or (f).				
	1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No								
	3. Copies of the certified copies			* -		Stage			
	application from the Internation	•	•						
* 5	See the attached detailed Office action			not received	i.				
Attachmen	l(s)								
	e of References Cited (PTO-892)			ew Summary (
	e of Draftsperson's Patent Drawing Review (F nation Disclosure Statement(s) (PTO-1449 or			No(s)/Mail Dat of Informal Pa		O-152)			
	r No(s)/Mail Date	1 10/36/00)	· -	5) Notice of Informal Patent Application (PTO-152) 6) Other:					

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DETAILED ACTION

Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1, 5, 6, 9 and 10 are rejected under 35 U.S.C. 103(a) as being unpatentable over admitted prior art (AAPA) in view of Cha et al. (US 6,486,933 B1), Choi et al. (US 6,429,918 B1) and Shimada et al. (US 5,870,157).

AAPA discloses a device and method comprising a pair of substrate (Fig. 17, ref. 200, 100); a liquid crystal sealed between the pair of substrates (300); a plurality of data lines and a plurality of scanning lines which are arranged so as to intersect each other on one surface of a first of the pair of substrates (Fig. 16, ref. 102, 106), a switching element having an electric current path, one end of which is connected to a corresponding one of the data lines, and having a control terminal which is connected to a corresponding one of the scanning lines (Fig. 16, res. 105), and having a control terminal which is connected to a corresponding one of the scanning lines (specs, page 3, lines 11-18); a pixel electrode which is provided above the data lines via an insulation film (112), and is connected to the other end of the electric current path of the switching element (Fig. 16, ref. 112); a common electrode which opposes that data line via the insulation film (111); a black matrix which is arranged on a second of the pair of substrates in a predetermined manner (202), the black matrix being covered by a flattening film (204). However, the reference does not disclose that the common electrode has slits in portions

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overlapping the data line, wherein at least some portions of the common electrode that are adjacent to the slits overlap at least some portions of the data lines, wherein the width of the portion of the black matrix is slightly larger than a width of a slit in a portion of the common electrode that is overlapping the data line.

Cha et al. discloses a common electrode having slits in portions overlapping the data lines, wherein at least some portions of the common electrode that are adjacent to the slits overlap at least some portions of the data lines (Fig. 7, ref. 320, 700), wherein the width of the portion of the black matrix (120) is slightly larger than a width of a slit in a portion of the common electrode that is overlapping the data line.

It would have been obvious to one having ordinary skill in the art at the time the invention was made for the common electrode to have slits in portions overlapping the data lines, wherein at least some portions of the common electrode that are adjacent to the slits overlap at least some portions of the data lines wherein the width of the portion of the black matrix is slightly larger than a width of a slit in a portion of the common electrode that is overlapping the data line since one would be motivated to "prevent the generation of abnormal electric field due to the potential difference between the data line and the pixel electrode" (col. 6, lines 30-33).

Furthermore, AAPA fails to disclose a first conductive film provided on the flattening film so as to oppose the data lines via the slits, the first conductive film being set to a common electric potential with the common electrode, wherein the first conductive film overlaps the portions of the common electrode where the slits are formed, , wherein an electric field can be generated between the common electrode and the pixel electrode, wherein the first conductive film is formed in a pattern that is the same as the black matrix.

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Choi et al. discloses a first conductive film provided on a flattening film so as to oppose the data lines (Fig. 3, ref. 37), the first conductive film being set to a common electric potential with the common electrode (col. 5, lines 1-4), wherein the first conductive film overlaps the portions of the common electrode (16a, 37), wherein an electric field can be generated between the common electrode and the pixel electrode (col. 5, lines 14-16), wherein the first conductive film is formed in a pattern that is the same as the black matrix (Fig. 3, ref. 37).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to employ a first conductive film provided on the flattening film so as to oppose the data lines via the slits, the first conductive film being set to a common electric potential with the common electrode, wherein the first conductive film overlaps the portions of the common electrode where the slits are formed, wherein an electric field can be generated between the common electrode and the pixel electrode and wherein the first conductive film is formed in a pattern that is the same as the black matrix since one would be motivated to prevent light leakage (col. 2, lines 13-18).

Moreover, AAPA fails to disclose that a portion of the black matrix that is located opposite a data line of the plurality of data lines has a width that is less than a width of the data line.

Shimada et al. discloses a device wherein a portion of the black matrix (16) that is located opposite a data line of the plurality of data lines (10) has a width that is less than a width of the data line (W2, W1a).

It would have been obvious to one having ordinary skill in the art at the time the invention was made for the black matrix that is located opposite a data line of the plurality of

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data lines to have a width that is less than a width of the data line since one would be motivated to improve the aperture ratio while realizing a desirable display (col. 3, lines 56-59).

3. Claims 2-4 and 7-8 rejected under 35 U.S.C. 103(a) as being unpatentable over AAPA, Cha et al. and Choi et al. and Shimada, in view of Lin et al. (6,757,031 B2).

Referring to claims 2-4 and 7-8, AAPA, Choi et al. and Chat et al. disclose the device and method previously recited. Choi et al. further discloses that the first conductive film has a pattern that is almost the same as that of the black matrix (37, 33), wherein the first conductive film is made of a transparent metal layer or an opaque metal layer (col. 4, lines 65-66). However, the reference does not disclose that the first conductive film is made of ITO or is made of a material having a low resistance.

Lin et al. discloses a device wherein a conductive film is made of ITO or is made of a material having a low resistance (col. 4, lines 45-46).

It would have been obvious to one having ordinary skill in the art at the time the invention was made for the conductive film to be made of ITO or is made of a material having a low resistance since one would be motivated to reduce power consumption.

Response to Arguments

4. Applicant's arguments with respect to claim have been considered but are moot in view of the new ground(s) of rejection.

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Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Richard H. Kim whose telephone number is (571)272-2294. The examiner can normally be reached on 9:00-6:30 M-F.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Robert H. Kim can be reached on (571)272-2293. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Richard H Kim Examiner Art Unit 2871

RHK

A Shirth ANDREW SCHECHTER PRIMARY EXAMINER